Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,824	BECK ET AL.	
Examiner	Art Unit	
Tianjie Chen	2652	

SEARCHED					
Class	Subclass	Date	Examiner		
360	122				
	119				
	120				
	121				
	126				
	127		r		
	57				
	243.3				
29	603.1				
264	51	10/28/2005	TJ		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Reports	10/28/2005	ŦJ		